

<b>Notice of References Cited</b>	Application/Control No. 10/782,613	Applicant(s)/Patent Under Reexamination TEO, JEFF BOON KIAT	
	Examiner Hiep T. Nguyen	Art Unit 2187	Page 1 of 1

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*	B	US-6,873,180	03-2005	Bentz, Ole	326/38
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